Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,056	ANDO, TAKESHI	
Examiner	Art Unit	
Chuck Huynh	2617	

	SEARCHED				
Class	Subclass	Date	Examiner		
Updated	Search	6/4/2007	At At		
455	432.1	6/4/2007	At		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
•					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Class/Subclass	6/4/2007	At		
Combined text search	6/4/2007	ZH		
Reviewed Applied Art	6/4/2007	At		